Low Capacitance Quad Array for ESD Protection

This integrated transient voltage suppressor device (TVS) is designed for applications requiring transient overvoltage protection. It is intended for use in sensitive equipment such as computers, printers, business machines, communication systems, medical equipment, and other applications. Its integrated design provides very effective and reliable protection for four separate lines using only one package. These devices are ideal for situations where board space is at a premium.

Features

- ESD Protection: IEC61000-4-2: Level 4
 - MILSTD 883C Method 3015-6: Class 3
- Four Separate Unidirectional Configurations for Protection
- Low Leakage Current < 1 μA @ 3 Volts
- Power Dissipation: 380 mW
- Small SOT-553 SMT Package
- Low Capacitance
- Complies to USB 1.1 Low Speed & High Speed Specifications
- These are Pb–Free Devices

Benefits

- Provides Protection for ESD Industry Standards: IEC 61000, HBM
- Protects the Line Against Transient Voltage Conditions in Either Direction
- Minimize Power Consumption of the System
- Minimize PCB Board Space

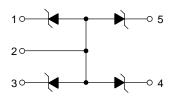
Typical Applications

- Instrumentation Equipment
- Serial and Parallel Ports
- Microprocessor Based Equipment
- Notebooks, Desktops, Servers
- Cellular and Portable Equipment



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SOT-553 CASE 463B PLASTIC

MARKING DIAGRAM



xx = Device Code
M = Date Code*
Pb-Free Package
(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NZQA5V6AXV5T1	SOT-553*	4000/Tape & Reel
NZQA5V6AXV5T1G	SOT-553*	4000/Tape & Reel
NZQA6V8AXV5T1	SOT-553*	4000/Tape & Reel
NZQA6V8AXV5T1G	SOT-553*	4000/Tape & Reel
NZQA6V8AXV5T3	SOT-553*	16000/Tape & Reel
NZQA6V8AXV5T3G	SOT-553*	16000/Tape & Reel

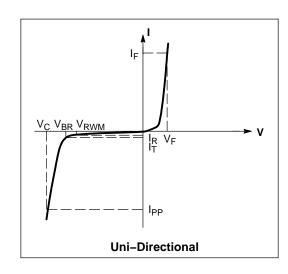
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{*}This package is inherently Pb-Free.

ELECTRICAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

Symbol	Parameter					
I _{PP}	Maximum Reverse Peak Pulse Current					
V _C	Clamping Voltage @ IPP					
V _{RWM}	Working Peak Reverse Voltage					
I _R	Maximum Reverse Leakage Current @ V _{RWM}					
V _{BR}	Breakdown Voltage @ I _T					
I _T	Test Current					
ΘV _{BR}	Maximum Temperature Coefficient of V _{BR}					
I _F	Forward Current					
V _F	Forward Voltage @ I _F					
Z _{ZT}	Maximum Zener Impedance @ I _{ZT}					
I _{ZK}	Reverse Current					
Z _{ZK}	Maximum Zener Impedance @ I _{ZK}					



MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Value	Unit
Peak Power Dissipation (8 X 20 μs @ T _A = 25°C) (Note 1)	P _{PK}	20	W
Steady State Power – 1 Diode (Note 2)	P _D	380	mW
Thermal Resistance, Junction–to–Ambient Above 25°C, Derate	$R_{ hetaJA}$	327 3.05	°C/W mW/°C
Maximum Junction Temperature	T _{Jmax}	150	°C
Operating Junction and Storage Temperature Range	T _J T _{stg}	-55 to +150	°C
Lead Solder Temperature (10 seconds duration)	T _L	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

ELECTRICAL CHARACTERISTICS $(T_A = 25^{\circ}C)$

	Device		down Vo	_	Leakage Current I _{RM} @ V _{RM}		V _C Max @ I _{PP}		Typ Capacitance @ 0 V Bias (pF) (Note 3)		Typ Capacitance @ 3 V Bias (pF) (Note 3)	
Device	Marking	Min	Nom	Max	V _{RWM}	I _{RWM} (μA)	V _C (V)	I _{PP} (A)	Тур	Max	Тур	Max
NZQA5V6AXV5	5P	5.3	5.6	5.9	3.0	1.0	13	1.6	13	17	7.0	11.5
NZQA6V8AXV5	6H	6.47	6.8	7.14	3.0	1.0	13	1.6	12	15	6.7	9.5

- Non-repetitive current per Figure 1.
 Only 1 diode under power. For all 4 diodes under power, P_D will be 25%. Mounted on FR-4 board with min pad.
 Capacitance of one diode at f = 1 MHz, V_R = 0 V, T_A = 25°C

TYPICAL ELECTRICAL CHARACTERISTICS - NZQA6V8AXV5

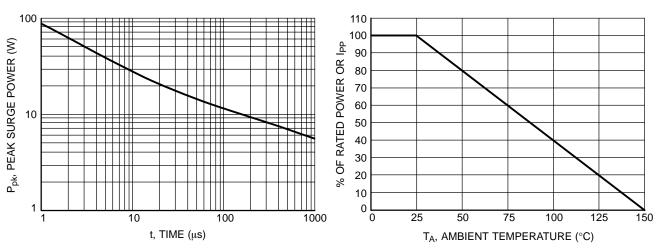


Figure 1. Pulse Width

Figure 2. Power Derating Curve

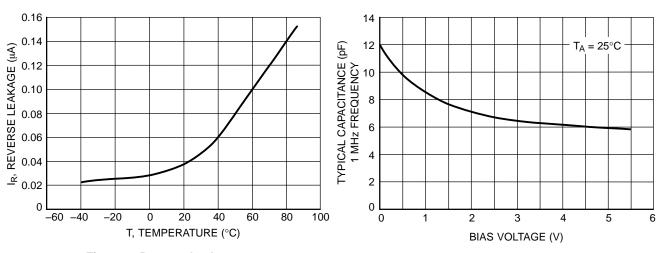


Figure 3. Reverse Leakage versus Temperature

Figure 4. Capacitance

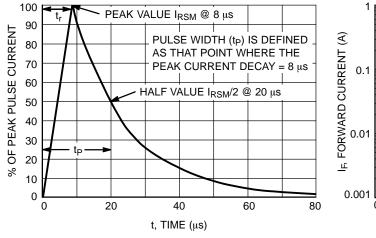


Figure 5. $8 \times 20 \mu s$ Pulse Waveform

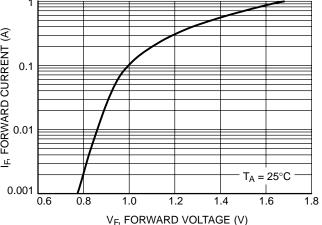
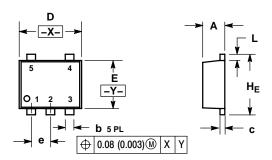


Figure 6. Forward Voltage

PACKAGE DIMENSIONS

SOT-553, 5 LEAD CASE 463B-01 ISSUE B



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982
- CONTROLLING DIMENSION: MILLIMETERS MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL

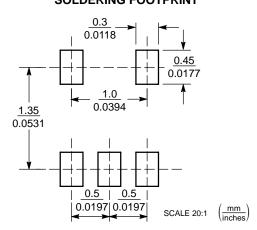
	М	ILLIMETE	RS	INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.50	0.55	0.60	0.020	0.022	0.024	
q	0.17	0.22	0.27	0.007	0.009	0.011	
n	0.08	0.13	0.18	0.003	0.005	0.007	
D	1.50	1.60	1.70	0.059	0.063	0.067	
Е	1.10	1.20	1.30	0.043	0.047	0.051	
е		0.50 BSC		0.020 BSC			
Г	0.10	0.20	0.30	0.004	0.008	0.012	
r 1	1 50	1.60	1.70	0.050	0.063	0.067	

STYLE 2

- PIN 1. CATHODE 2. COMMON ANODE 3. CATHODE 2 4. CATHODE 3

 - 5. CATHODE 4

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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